

## N-Channel 30-V (D-S) MOSFET

### PRODUCT SUMMARY

$V_{DS}$ (V)	$r_{DS(on)}$ ( $\Omega$ )	$I_D$ (A) <sup>a</sup>	$Q_g$ (Typ)
30	0.024 at $V_{GS} = 10$ V	6	11 nC
	0.030 at $V_{GS} = 4.5$ V	6	

### FEATURES

- TrenchFET® Power MOSFET

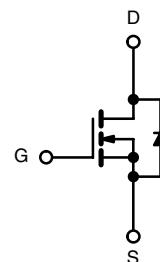
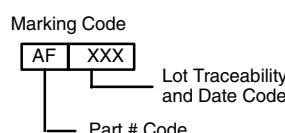
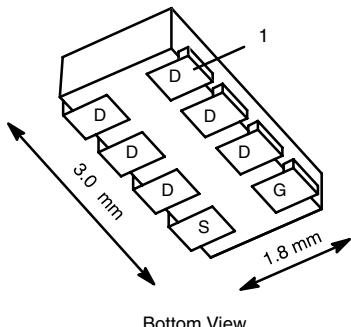


**RoHS**  
COMPLIANT

### APPLICATIONS

- Load Switch
  - Notebook PC

ChipFET 1206-8



Ordering Information: Si5424DC-T1-E3 (Lead (Pb)-free)

N-Channel MOSFET

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 25$	
Continuous Drain Current ( $T_J = 150^\circ\text{C}$ )	$I_D$	6 <sup>a</sup>	A
		6 <sup>a</sup>	
		6 <sup>a</sup>	
		6 <sup>a</sup>	
Pulsed Drain Current	$I_{DM}$	40	
Continuous Source-Drain Diode Current	$I_S$	5.2 <sup>a</sup>	
		2.1 <sup>b, c</sup>	
Avalanche Current	$I_{AS}$	16	
Single Pulse Avalanche Energy	$E_{AS}$	12.8	mJ
Maximum Power Dissipation	$P_D$	6.25	W
		4.0	
		2.5 <sup>b, c</sup>	
		1.6 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to 150	$^\circ\text{C}$
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260	

### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, f</sup>	$R_{thJA}$	40	50	$^\circ\text{C}/\text{W}$
Maximum Junction-to-Foot (Drain)	$R_{thJF}$	15	20	

Notes:

- Package limited.
- Surface Mounted on 1" x 1" FR4 Board.
- t = 5 sec.
- See Solder Profile (<http://www.vishay.com/doc?73257>). The ChipFET 1206-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under steady state conditions is 80 °C/W.

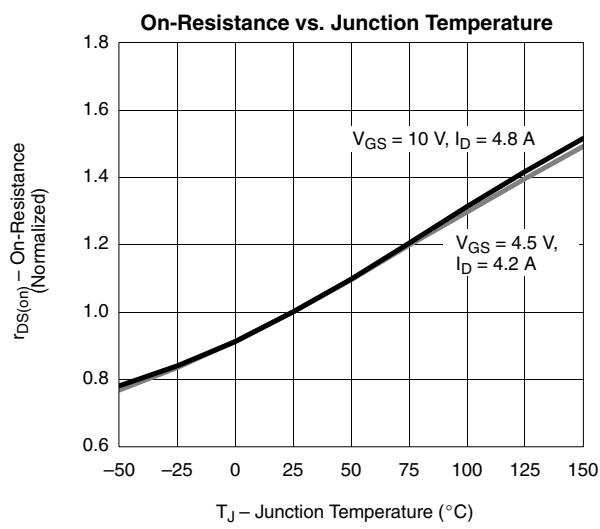
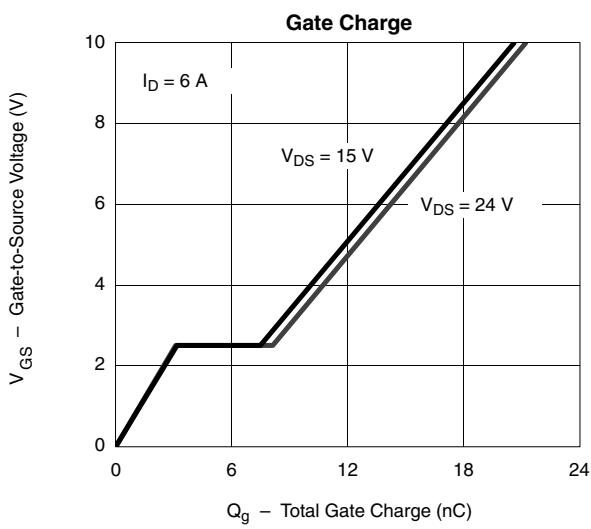
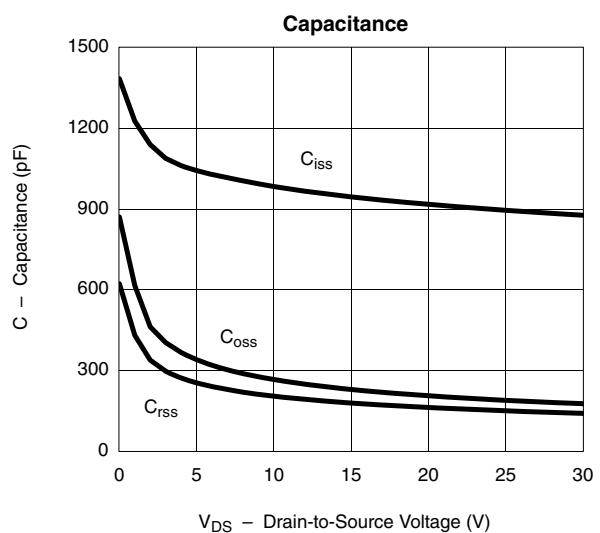
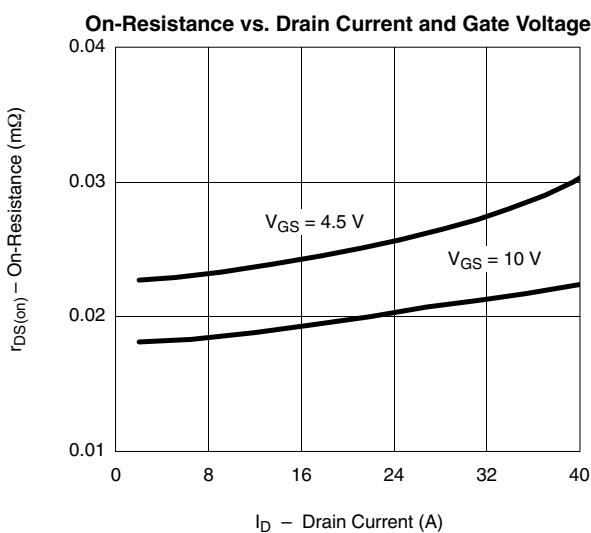
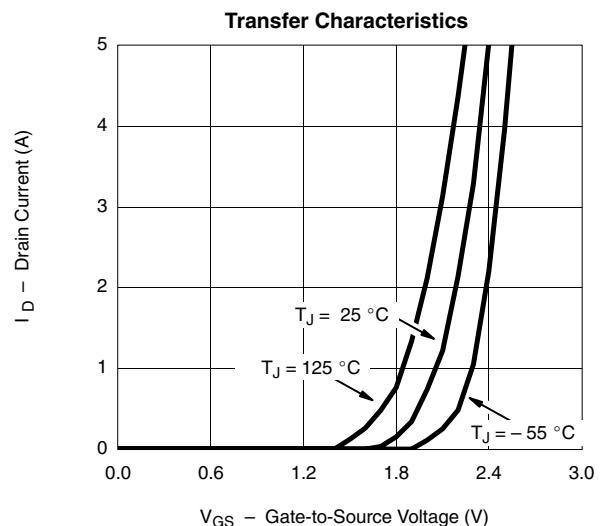
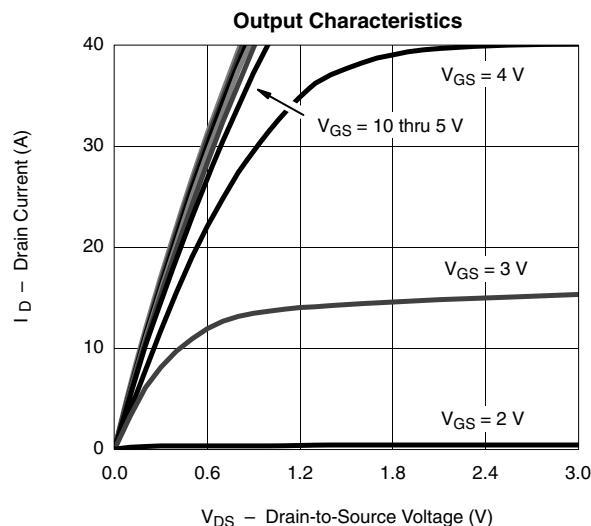
**SPECIFICATIONS ( $T_J = 25^\circ\text{C}$  UNLESS OTHERWISE NOTED)**

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$		19.4		$\text{mV}/^\circ\text{C}$
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			-4.6		
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	1.1		2.3	V
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			$\pm 100$	ns
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$		1		$\mu\text{A}$
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$		10		
On-State Drain Current <sup>a</sup>	$I_{D(\text{on})}$	$V_{DS} \geq 5 \text{ V}, V_{GS} = 10 \text{ V}$	40			A
Drain-Source On-State Resistance <sup>a</sup>	$r_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}, I_D = 4.8 \text{ A}$	0.020	0.024		$\Omega$
		$V_{GS} = 4.5 \text{ V}, I_D = 4.22 \text{ A}$	0.024	0.030		
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 15 \text{ V}, I_D = 4.8 \text{ A}$		17		S
<b>Dynamic<sup>b</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		950		$\text{pF}$
Output Capacitance	$C_{oss}$			230		
Reverse Transfer Capacitance	$C_{rss}$			180		
Total Gate Charge	$Q_g$	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 4.8 \text{ A}$	21	32		$\text{nC}$
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.8 \text{ A}$	11	17		
Gate-Drain Charge	$Q_{gd}$		3.2			
Gate Resistance	$R_g$		4.2			
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = 15 \text{ V}, R_L = 2.63 \Omega$ $I_D \approx 5.7 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	f = 1 MHz	2.2		$\Omega$
Rise Time	$t_r$			17	26	$\text{ns}$
Turn-Off Delay Time	$t_{d(\text{off})}$			75	113	
Fall Time	$t_f$			22	33	
Turn-On Delay Time	$t_{d(\text{on})}$			12	18	
Rise Time	$t_r$	$V_{DD} = 15 \text{ V}, R_L = 2.5 \Omega$ $I_D \approx 6 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		10	15	$\text{ns}$
Turn-Off Delay Time	$t_{d(\text{off})}$			38	57	
Fall Time	$t_f$			26	40	
Turn-On Delay Time	$t_{d(\text{on})}$			9	14	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25^\circ\text{C}$		6		$\text{A}$
Pulse Diode Forward Current	$I_{SM}$			40		
Body Diode Voltage	$V_{SD}$	$I_S = 4.3 \text{ A}, V_{GS} = 0 \text{ V}$	0.8	1.2		V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 4.3 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}, T_J = 25^\circ\text{C}$	24	36		ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		11	17		nC
Reverse Recovery Fall Time	$t_a$		9			$\text{ns}$
Reverse Recovery Rise Time	$t_b$		15			

## Notes

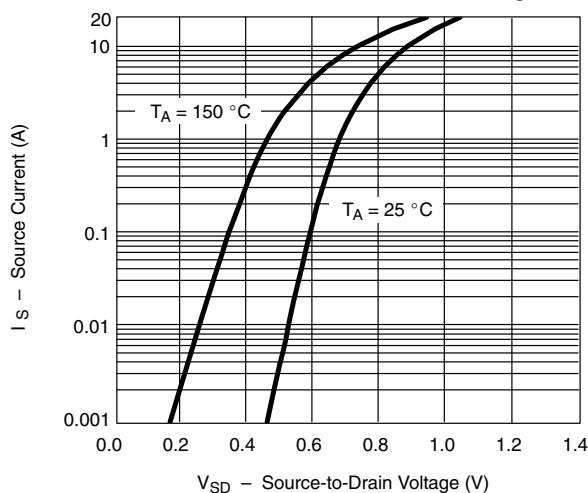
- a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

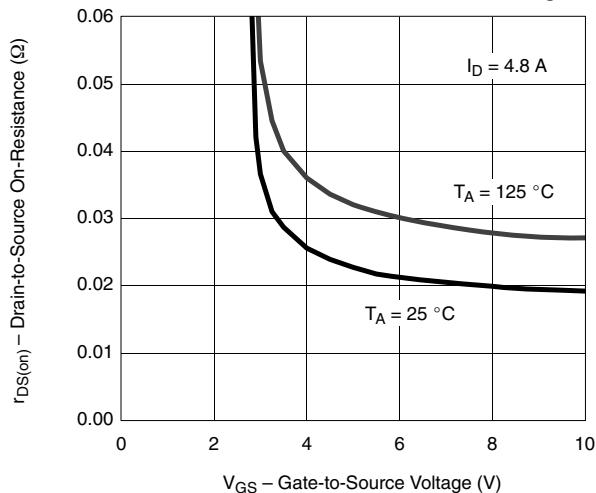
**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)**


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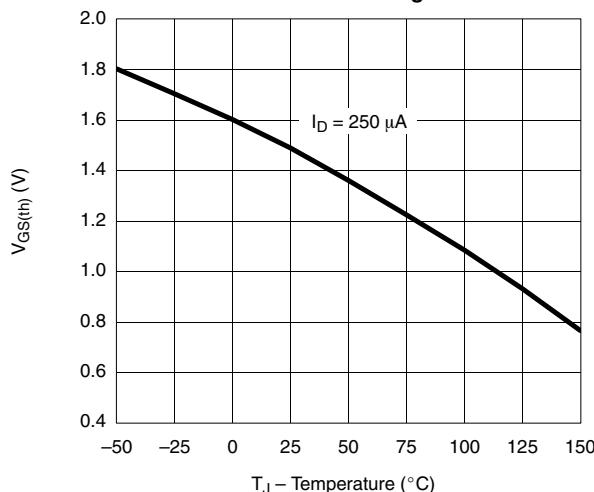
Source-Drain Diode Forward Voltage



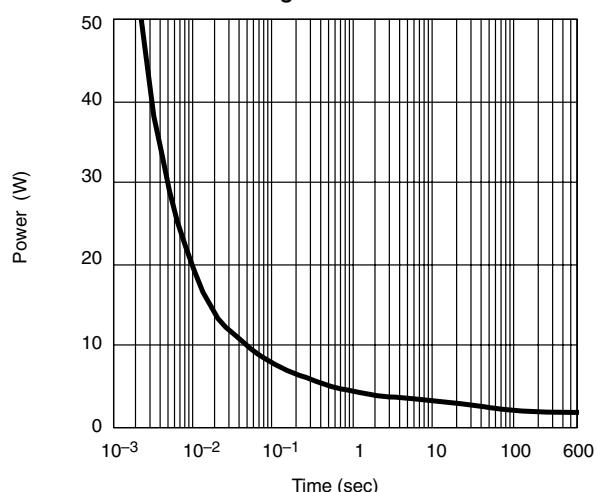
On-Resistance vs. Gate-to-Source Voltage



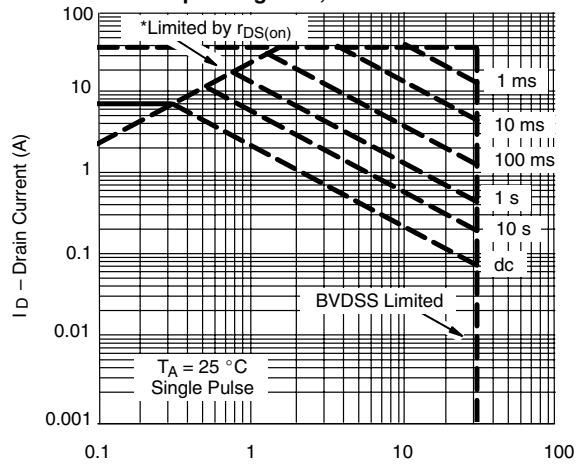
Threshold Voltage



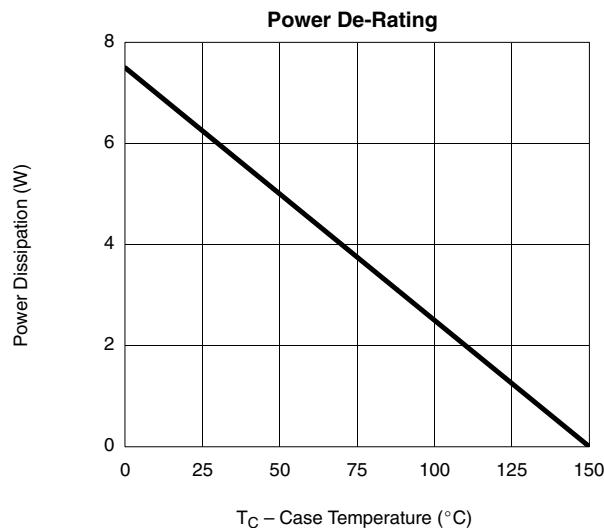
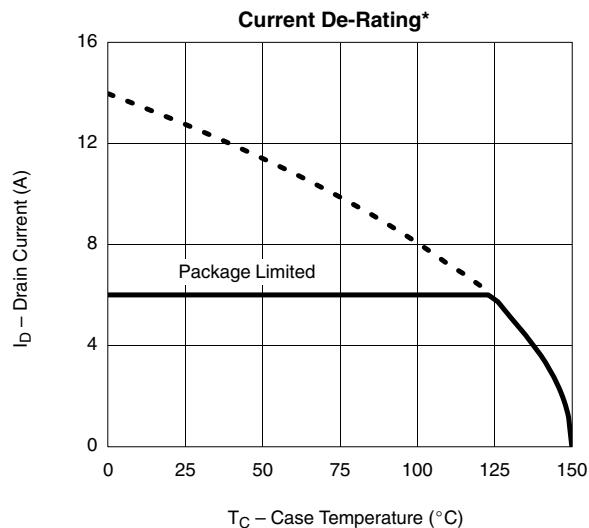
Single Pulse Power



Safe Operating Area, Junction-to-Ambient



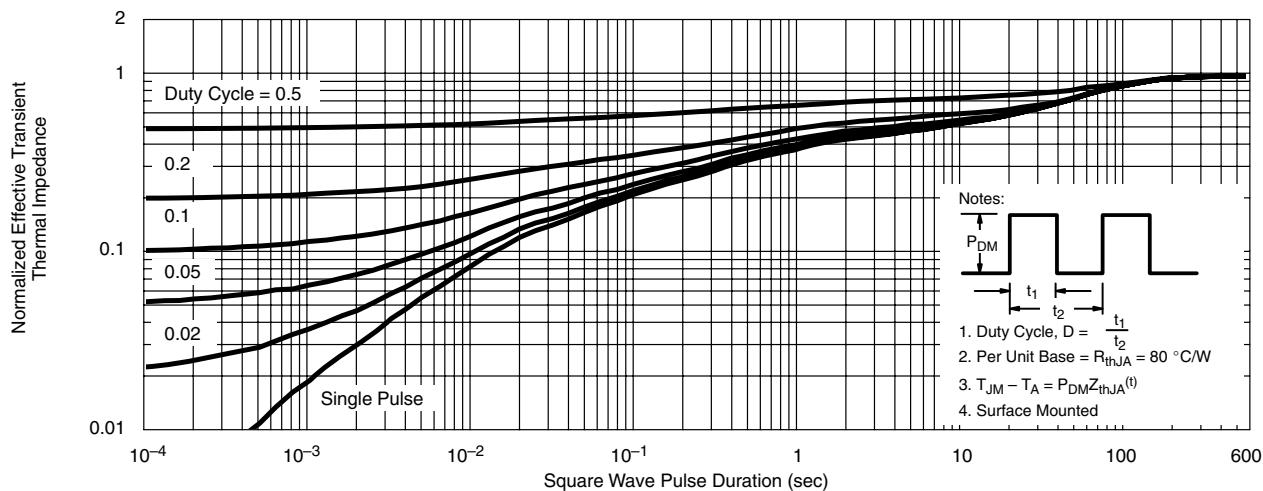
$V_{DS}$  – Drain-to-Source Voltage (V)  
 $*V_{GS} >$  minimum  $V_{GS}$  at which  $r_{DS(on)}$  is specified

**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)**


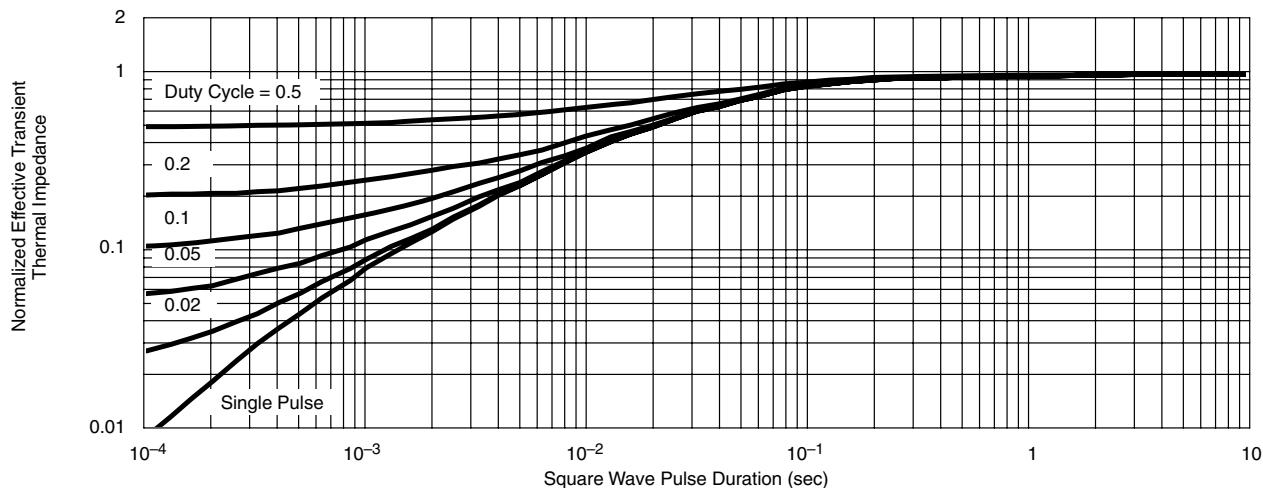
\*The power dissipation  $P_D$  is based on  $T_{J(max)} = 150 \text{ }^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)**

Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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